

### NCE65T360-VB Datasheet

### N-Channel 650V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V) at T <sub>J</sub> max.	650				
R <sub>DS(on)</sub> at 25 °C (Ω)	V <sub>GS</sub> = 10 V 0.23				
Q <sub>g</sub> Typ. (nC)	24				
Q <sub>gs</sub> (nC)	6				
Q <sub>gd</sub> (nC)	11				
Configuration	Single				

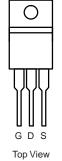
### FEATURES

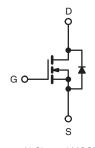
- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (C<sub>iss</sub>)
- · Reduced switching and conduction losses
- Ultra low gate charge (Q<sub>q</sub>)
- Avalanche energy rated (UIS)

### **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial
  - Welding
  - Induction heating
  - Motor drives
  - Battery chargers
  - Renewable energy
  - Solar (PV inverters)

TO-220AB	





N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_C = 25 \text{ °C}$ , unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	650	V	
Gate-Source Voltage			V <sub>GS</sub>	± 30	v	
Continuous Drain Current (T 150 °C)	$V_{\rm ext} = 0.10$ V	$T_{\rm C} = 25 \ ^{\circ}{\rm C}$ $T_{\rm C} = 100 \ ^{\circ}{\rm C}$	I_	15		
Continuous Drain Current ( $T_J = 150 \ ^{\circ}C$ )	$V_{\rm GS}$ at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	10	A	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	45		
Linear Derating Factor				1.4	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	286	mJ	
Maximum Power Dissipation			P <sub>D</sub>	180	W	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Drain-Source Voltage Slope	T <sub>J</sub> = 125 °C		d)//dt	37	1//20	
Reverse Diode dV/dt d			dV/dt	23	V/ns	
Soldering Recommendations (Peak Temperature) c for 10 s			300	°C		

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

b.  $V_{DD} = 50$  V, starting  $T_J = 25$  °C, L = 28.2 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 4.5$  A.

c. 1.6 mm from case.

d.  $I_{SD} \leq I_D, \, dI/dt = 100$  A/µs, starting  $T_J = 25 \ ^\circ C.$ 





THERMAL RESISTANCE RATI	NGS							
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	- 62			0044		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 0.7						
SPECIFICATIONS (T <sub>J</sub> = 25 $^{\circ}$ C, u	nless otherwi	se noted)						
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static		+			•			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	= 0 V, I <sub>D</sub> =	250 µA	650	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	I <sub>D</sub> = 1 mA	-	0.75	-	V/°C
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> =	250 µA	2	-	4	V
			$V_{GS} = \pm 20$		-	-	± 100	nA
Gate-Source Leakage	I <sub>GSS</sub>		$V_{GS} = \pm 30$	V	-	-	± 1	μA
			= 650 V, V <sub>C</sub>		-	-	1	-
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		$V_{DS} = 520 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 125 \text{ °C}$		-	-	10	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V		I <sub>D</sub> = 8 A	-	0.23	-	Ω
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> = 30 V, I <sub>D</sub> = 8 A		-	5.6	-	S	
Dynamic		1			1	1	1	1
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V,		-	1640	-		
Output Capacitance	C <sub>oss</sub>		$v_{GS} = 0 V,$ $V_{DS} = 100 V,$		-	80	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1 MHz		-	4	-	pF	
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>	$V_{DS} = 0$ V to 520 V, $V_{GS} = 0$ V		-	63	-		
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>			-	213	-		
Total Gate Charge	Qg	V <sub>GS</sub> = 10 V I <sub>D</sub> = 8 A, V <sub>DS</sub> = 520 V		-	24	48	nC	
Gate-Source Charge	Q <sub>gs</sub>			-	6	-		
Gate-Drain Charge	Q <sub>gd</sub>				-	11	-	
Turn-On Delay Time	t <sub>d(on)</sub>				-	18	36	
Rise Time	t <sub>r</sub>	$V_{DD} = 520 \text{ V}, \text{ I}_{D} = 8 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{g} = 9.1 \Omega$		-	24	48	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	48	96		
Fall Time	t <sub>f</sub>			-	25	50		
Gate Input Resistance	Rg	f = 1	MHz, ope	n drain	-	0.8	-	Ω
Drain-Source Body Diode Characteristic	cs	1						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	15	А	
Pulsed Diode Forward Current	I <sub>SM</sub>			-	-	38	~	
Diode Forward Voltage	V <sub>SD</sub>	$T_{J} = 25 \text{ °C}, I_{S} = 8 \text{ A}, V_{GS} = 0 \text{ V}$		-	-	1.2	V	
Reverse Recovery Time	t <sub>rr</sub>		-		-	325	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = I_S = 8 \text{ A},$ dI/dt = 100 A/ $\mu$ s, V <sub>R</sub> = 400 V		-	4.6	-	μC	
Reverse Recovery Current	I <sub>RRM</sub>			-	20	-	A	
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#### Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

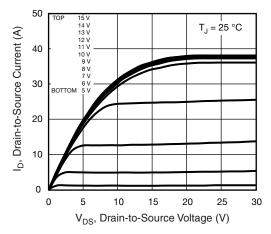


Fig. 1 - Typical Output Characteristics

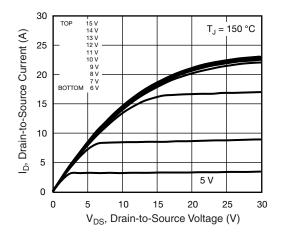


Fig. 2 - Typical Output Characteristics

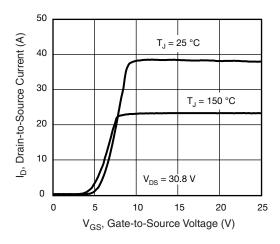


Fig. 3 - Typical Transfer Characteristics

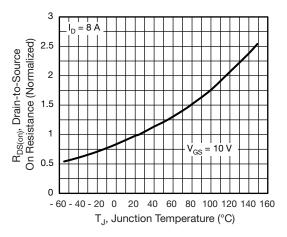


Fig. 4 - Normalized On-Resistance vs. Temperature

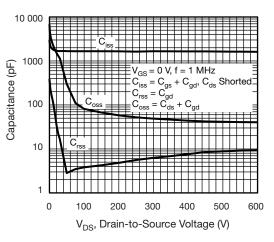


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

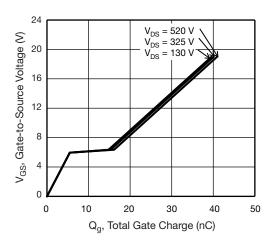


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

### NCE65T360-VB



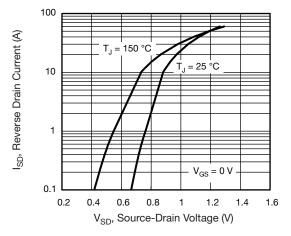


Fig. 7 - Typical Source-Drain Diode Forward Voltage

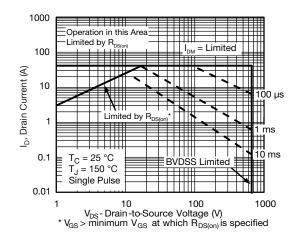


Fig. 8 - Maximum Safe Operating Area

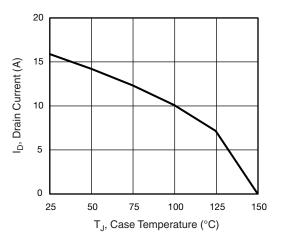


Fig. 9 - Maximum Drain Current vs. Case Temperature

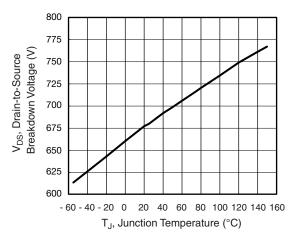


Fig. 10 - Temperature vs. Drain-to-Source Voltage

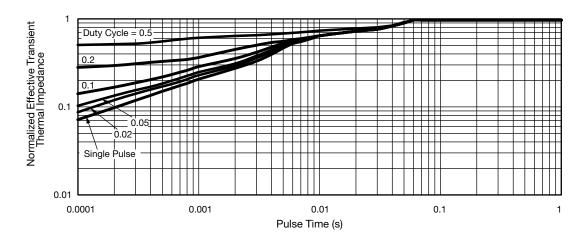


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



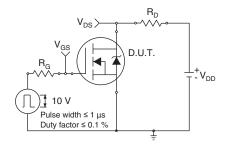


Fig. 12 - Switching Time Test Circuit

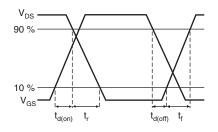


Fig. 13 - Switching Time Waveforms

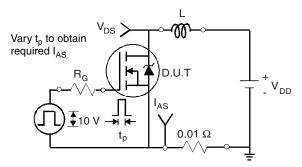


Fig. 14 - Unclamped Inductive Test Circuit

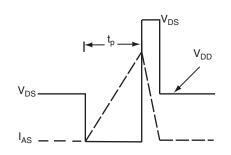


Fig. 15 - Unclamped Inductive Waveforms

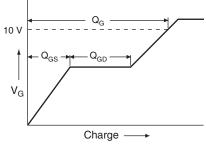


Fig. 16 - Basic Gate Charge Waveform

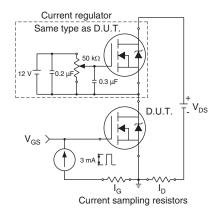
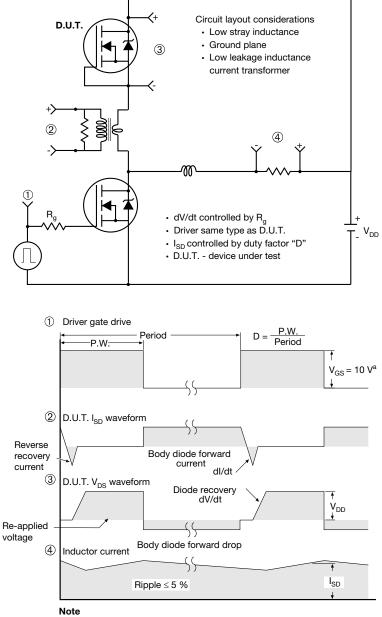


Fig. 17 - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit

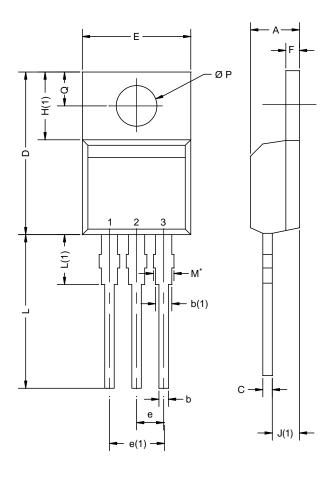


a.  $V_{GS} = 5$  V for logic level devices

Fig. 18 - For N-Channel



# **TO-220AB**



	MILLIN	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
А	4.25	4.65	0.167	0.183		
b	0.69	1.01	0.027	0.040		
b(1)	1.20	1.73	0.047	0.068		
С	0.36	0.61	0.014	0.024		
D	14.85	15.49	0.585	0.610		
E	10.04	10.51	0.395	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.09	6.48	0.240	0.255		
J(1)	2.41	2.92	0.095	0.115		
L	13.35	14.02	0.526	0.552		
L(1)	3.32	3.82	0.131	0.150		
ØР	3.54	3.94	0.139	0.155		
Q	2.60	3.00	0.102	0.118		
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471						

#### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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